Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/612,477	CHENG ET AL.	
Examiner	Art Unit	
Kevin C. Harner	2666	

	SEARCHED				
Class	Subclass	Date	Examiner		
370	328, 464, 465, 469	4/26/2005	ксн		
714	1, 100	4/26/2005	ксн		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST text search	4/17/2005	ксн
IEEE XPLORE (RLP and H-ARQ)	4/17/2005	ксн
Inventorship search on PALM	4/28/2005	ксн
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